EMC TEST REPORT

EN 55032:2015+A1:2020 EN 55035:2017+A11:2020 EN IEC 61000-3-2:2019+A1:2021 EN 61000-3-3:2013+A1:2019+A2:2021 MEASUREMENT AND TEST REPORT

OpenVox Communication Co., Ltd

Room 624, 6/F, Tsinghua Information Port, Qingqing Road, Longhua Street, Longhua District, Shenzhen,Guangdong ,China

Model: DGW-L301

2022-12-15

This Report Concerns:	Equipment Type:
Original Report	E1/T1 Gateway
Test Engineer: Sinphy Xie/ Simple	hy Co
Report Number: TH2212087-C01-R0	
Test Date: 2022-12-09 to 2022	一世四九百七十十
Reviewed By: Neo Dong/ Neo	Von
Approved By: Binglee/ Single	lee the the test of the test o
Prepared By: Shenzhen Tian Ha	i Test Technology Co.,Ltd.
S	

Note: This test report is limited to the above client company and the product model only. It may not be duplicated without prior written consent of TianHai Compliance Testing Laboratory Ltd.

TABLE OF CONTENTS

1 - SUMMARY OF STANDARDS AND RESULTS	3
1.1 DESCRIPTION OF STANDARDS AND RESULTS	
1.2 DESCRIPTION OF PERFORMANCE CRITERIA	
2 - GENERAL INFORMATION	
2.1 PRODUCT DESCRIPTION FOR EQUIPMENT UNDER TEST	
Model: SK01T8-1200100Z	
Input: 100-240V~50/60Hz 0.4A Max	5
Output: DC 12.0V, 1.0A 12.0W	5
2.2 STATEMENT OF THE MEASUREMENT UNCERTAINTY TEST FACILITY	
2.3 MEASUREMENT UNCERTAINTY	5
2.4 TEST LOCATION	
2.5 PRINCIPLE OF CONFIGURATION SELECTION	
2.7 SPECIAL ACCESSORIES AND AUXILIARY EQUIPMENT	
3 - TEST EQUIPMENT LIST AND DETAILS	7
4 - CONDUCTED EMISSION MEASUREMENT	
4.1 BLOCK DIAGRAM OF TEST SETUP	
4.2 LIMITS	
4.3 TEST PROCEDURE	9
4.4 TEST RESULTS AND DATA	
5 - ASYMMETRIC MODE CONDUCTED EMISSION MEASUREMENT	12
5.1 BLOCK DIAGRAM OF TEST SETUP	
5.2 LIMITS	
5.3 TEST PROCEDURE	
6 - RADIATED DISTURBANCE MEASUREMENT	
6.1 BLOCK DIAGRAM OF TEST SETUP	
6.2 LIMITS	
6.3 TEST PROCEDURE	15
6.4 TEST RESULTS AND DATA	
7 - HARMONIC CURRENT EMISSION MEASUREMENT	
7.1 BLOCK DIAGRAM OF TEST SETUP	20
7.2 TEST STANDARD	
7.3 TEST PROCEDURE	20
8 - VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT	
8.1 BLOCK DIAGRAM OF TEST SETUP	
8.2 TEST STANDARD	
8.3 TEST PROCEDURE	21
8.4 TEST RESULTS	21
9 - IMMUNITY TEST	
9.1 ELECTROSTATIC DISCHARGE IMMUNITY TEST	
9.2 RADIO FREQUENCY ELECTROMAGNETIC FIELDS	
9.4 SURGE IMMUNITY TEST	
9.5 INJECTED CURRENTS SUSCEPTIBILITY TEST	
9.6 VOLTAGE DIPS AND INTERRUPTIONS TEST	32
APPENDIX A - EUT PHOTOGRAPHS	33

Report No.: TH2212087-C01-R01

1 - SUMMARY OF STANDARDS AND RESULTS

1.1 DESCRIPTION OF STANDARDS AND RESULTS

The EUT have been tested according to the applicable standards as referenced below.

	Li	MISSION		
Description of Test Item	Test Standard	Basic Standard	Requirement	Results
Conducted disturbance at mains terminals	EN 55032:2015+ A1:2020	EN 55032:2015+ A1:2020	Class A	PASS
Asymmetric mode conducted emission	EN 55032:2015+ A1:2020	EN 55032:2015+ A1:2020	Class A	PASS
Radiated disturbance	EN 55032:2015+ A1:2020	EN 55032:2015+ A1:2020	Class A	PASS
Harmonic current emissions	EN IEC 61000-3-2: 2019+A1:2021	EN IEC 61000-3-2: 2019+A1:2021	Class A	PASS
Voltage fluctuations &	EN 61000-3-3:2013 +A1:2019+A2:2021	EN 61000-3-3:2013 +A1:2019+A2:2021	Clause 5	PASS
	IM	MUNITY		
Description of Test Item	Test Standard	Basic Standard	Test configuration	Results
Electrostatic discharge (ESD)	EN 55035:2017+ A11:2020	IEC 61000-4-2:2008	Air Discharge: ±2KV, ±4KV, ±8KV Contact Discharge: ±2kV,±4kV	PASS
Radio-frequency, Continuous radiated disturbance EN 55035:2017 A11:2020		IEC 61000-4-3:2020	1%1kHz, 80% AM, 80 ~ 1000MHz, 1800MHz,2600MHz 3500MHz,6000MHz 3V/m	PASS
Electrical fast transient (EFT)	EN 55035:2017+ A11:2020	IEC 61000-4-4:2012	Tr/Td 5/50 ns, 5kHz, AC power port: ±1kV Signal port: ±0.5kV	PASS
Surge	EN 55035:2017+ A11:2020	IEC 61000-4-5:2014 +AMD1:2017	AC power port: 1.2/50 (8/20) Tr/Th us, line to line: ±1.0kV line to PE: ±2.0kV Signal port: 10/700 (8/320) Tr/Th us,±0.5kV	PASS
Radio-frequency, Continuous conducted disturbance	EN 55035:2017+ A11:2020	IEC 61000-4-6:2013	1%1kHz, 80%, AM Mod. 0.15 ~ 10MHz: 3V/m 10 ~ 30MHz: 3V/m to1V/m 30 ~ 80MHz: 1V/m	PASS
Power frequency Magnetic field*	EN 55035:2017+ A11:2020	IEC 61000-4-8:2009	- 11	N/A

Report No.: TH2212087-C01-R01 Page 3 of 37 EN 55032 Report

Voltage dips, <5% reduction	7	Z.F	0.5 Cycle for 50Hz 0.5 Cycle for 60Hz	PASS
Voltage dips, 70% reduction	EN 55035:2017+ A11:2020	IEC 61000-4-11: 2020	25 Cycle for 50Hz 30 Cycle for 60Hz	PASS
Voltage interruptions <5% reduction	N. W.	5 A	250 Cycle for 50Hz 300 Cycle for 60Hz	PASS

Remark:

N/A is an abbreviation for Not Applicable.

"*": The EUT does not contain devices susceptible to magnetic fields; therefore the Power-Frequency Magnetic Fields test is not necessary.

1.2 DESCRIPTION OF PERFORMANCE CRITERIA

General Performance Criteria

General performance criteria are defined in 8.2, 8.3 and 8.4. These criteria shall be used during the testing of primary functions where no relevant annex is applicable. When assessing the impact of a disturbance on a function, the assessment should take into consideration the function's performance prior to the application of the disturbance and only identify as failures those changes in performance that are a result of the disturbance.

1.2.1 Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.2 Performance criterion B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test. After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.3 Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed.

Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Report No.: TH2212087-C01-R01 Page 4 of 37 EN 55032 Report

2 - GENERAL INFORMATION

2.1 PRODUCT DESCRIPTION FOR EQUIPMENT UNDER TEST

Client Information

Applicant: OpenVox Communication Co., Ltd

Address: Room 624, 6/F, Tsinghua Information Port, Qingqing Road, Longhua Street,

Longhua District, Shenzhen, Guangdong, China

Manufacturer: OpenVox Communication Co., Ltd

Room 201, Building I, Jinchangda, Building 00082, Shangwei Industrial Zone,

Address: Zhangkengjing Community, Guanhu Street, Longhua District, Shenzhen,

Guangdong, China

General Description of E.U.T

EUT Name: E1/T1 Gateway

Trade Mark: OpenVox

Model No.: DGW-L301

Sample No.: TH2212087

DC 12V power from AC/DC ADAPTER:

Ratings: Model: SK01T8-1200100Z

Input: 100-240V~50/60Hz 0.4A Max

Output: DC 12.0V, 1.0A 12.0W

A. On

Test Mode: 1.Full system

2.RJ45 10Mbps

3.RJ45 100Mbps

Note: /

2.2 STATEMENT OF THE MEASUREMENT UNCERTAINTY TEST FACILITY

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration Limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. To CISPR 16-4-2 "Specification for radio disturbance and immunity measuring apparatus and methods - Part 4-2: Uncertainties, statistics and limit modelling – Measurement instrumentation uncertainty" and is documented in the LCS quality system acc. To DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

2.3 MEASUREMENT UNCERTAINTY

Test	Parameters	Expanded uncertainty (U _{lab})	Expanded uncertainty (U _{cispr})
Conducted Emission	Level accuracy (9kHz to 150kHz) (150kHz to 30MHz)	± 2.52 dB ± 2.36 dB	\pm 3.80 dB \pm 3.40 dB
Power disturbance	Level accuracy (30MHz to 300MHz)	±3.20dB	±4.50 dB

Report No.: TH2212087-C01-R01 Page 5 of 37 EN 55032 Report

Electromagnetic Radiated Emission (3-loop)	Radiated Level accuracy (9kHz to 30MHz)		N/A	
Radiated emission	Level accuracy (30MHz to 1000MHz)	±5.78dB	± 6.30 dB	
Radiated emission	Level accuracy (above 1000MHz)	\pm 4.62dB	N/A	
Mains Harmonic	Voltage	±1.80%	N/A	
Voltage Fluctuations & Flicker	Voltage	±0.64%	N/A	

⁽¹⁾ Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus.

(3) The measurement uncertainty is not included in the test result.

2.4 TEST LOCATION

All tests were performed at Shenzhen Tianhai Test Technology Co., Ltd. 125-126, No.66, Zhangge Road ,Zhangge Community, Fucheng Street, Longhua District, Shenzhen, Guangdong Province, P.R. China

2.5 PRINCIPLE OF CONFIGURATION SELECTION

Emission: The equipment under test (EUT) was configured to measure its highest possible radiation level. The test modes were adapted accordingly in reference to the instructions for use. Immunity: The equipment under test (EUT) was configured to have its highest possible susceptibility against the tested phenomena. The test modes were adapted accordingly in reference to the instructions for use.

2.6 TEST OPERATION

Test operation refers to test setup in chapter 4 & 5 & 6 & 7 & 8 & 9. Pre-test in all operation modes, and find out the worst case for compliance test.

2.7 SPECIAL ACCESSORIES AND AUXILIARY EQUIPMENT

The EUT was tested together with the following accessories:

Kind of Equipment	Manufacturer	Туре	S/N
Notebook	DELL	Inspiron 3501	1 112
7	7 3	1	1 3

The EUT was tested with following cables:

Cable name	Length (m)	Shield	Core No.	Detachable
Network cable	1.5m	No	L	J. Br
Network cable	1.0m	No	7	1

Report No.: TH2212087-C01-R01 Page 6 of 37 EN 55032 Report

⁽²⁾ The reported expanded uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor of k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

3 - TEST EQUIPMENT LIST AND DETAILS

Kind of Equipment	Manufacturer	Туре	S/N	Calibrate until
Conducted Emission	£ 29	4	20 6	14
EMI Test Receiver	R&S	ESR7	102333	2023-11-13
L.I.S.N	Schwarzbeck	NNLK 8128	5089	2023-11-13
8-Wire ISN CAT6	Schwarzbeck	NTFM 8158	231	2023-11-13
Pulse Limiter	Schwarzbeck	VTSD 9561-F	847	2023-11-13
Test software	FALA	12 2	EMC-CON 3A1.1	1 6
Radiated Emission (3m	1)		Zin Zin	5
EMI Test Receiver	R&S	ESR7	102333	2023-11-13
MXA Signal Analyzer	Keysight	N9020A	MY51281805	2023-04-15
Bilog Antenna	Schwarzbeck	VULB 9168	01148	2023-11-20
Pre-Amplifier	Schwarzbeck	BBV 9718 B	00109	2023-11-13
Pre-Amplifier	Schwarzbeck	BBV 9743 B	00253	2023-11-13
Horn Antenna	Schwarzbeck	BBHA 9120	02379	2023-11-20
Test software	FALA	1	FA-03A2 RE	1
Harmonics & Flicker		6 4	W.	J. S.
5kVA AC Power Source	AMETEK CTS	5001iX-CTS-400	2046A03237	2023-11-13
Signal Conditioning Unit	AMETEK CTS	PACS-1	2046A03238	2023-11-13
Test software	AMETEK CTS	CTS 4	Version 4.26.0	1
Electrostatic discharge	e (ESD)	0		15
ESD Simulator	TESEQ	NSG 437	1569	2023-11-15
Pistol	TESEQ	V06.04	1 3 3	7
Base Station	TESEQ	V06.02	1 8	1 2
Radio-frequency,Conti	nuous radiated c	listurbance (RS)	Z ³	K _a
Signal generator	R&S	SMB 100A	113650	2023-04-15
Power meter	Agilent	E4417A	MY45100899	2023-04-15
Power sensor	Agilent	E9321A	US40390494	2023-04-15
Power sensor	Agilent	E9322A	MY44420219	2023-04-15
	240	MPA-80-1000-	18	2023-04-15

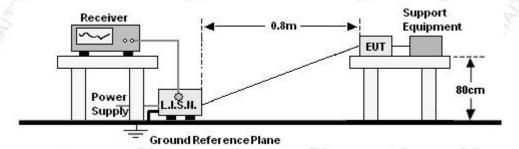
Report No.: TH2212087-C01-R01 Page 7 of 37 EN 55032 Report

Power amplifier	Micotop	MPA-1000-6000- 100	MPA2201013	2023-04-15
Stacked Log. Periodic Antenna	Schwarzbeck	STLP 9129	201	1 29
RF Switch	Emtrace	SW X4	T Li	128
Test Software	Emtrace	EM 3	V1.2.1	T A
Electrical fast transien	t (EFT)	Z. C.	N. S.	182
Burst Tester	3C test	EFT 500T	ES027000120015	2023-11-13
Coupling Clamp	3C test	CCC 100	CCC 20092269	2023-11-13
Test Software	3C test	V4.2.7	ES027000120015	1 2
Surge	18 ² 35	F 182	The The	Zill.
Surge simulator	3C test	CWS 600CT	ES058000920005	2023-11-13
Three phases CDN	3C test	SPN 3832T	ES0911910	2023-11-13
CDN for unshielded symmetrical high-speed Telecom cable	3C test	CDN405T8A	ES064001220010	2023-11-13
CDN for Telecom cable	3C test	CDN405M40-5	ES1071910	2023-11-13
Test Software	3C test	V1.0.5.2	ES058000920005	1
Radio-frequency,Conti	nuous conducte	ed disturbance (CS)	E C	8
Conducted Immunity Test System	3C test	CST 1075	ES096000120008	2023-11-13
6dB Attenuator	3C test	DTC75-6	ES095000120006	2023-11-13
Single phase CDN	3C test	CDN M2M3	ES064002620007	2023-11-13
Three phases CDN	3C test	CDN M5-16	ES064003320004	2023-11-13
Calibration Set	3C test	CDN 100KIT	ES064002820016	2023-11-13
Calibration Set	3C test	EM CL100KIT	EM C20032816	2023-11-13
EM-Clamp	3C test	EM CL100	EM C20032811	2023-11-13
Test software	SKET	1	V1.4.0.54	1
Voltage dips &Voltage	interruptions	^	^	
Power failure simulator	3C test	PFS 2216SD	ES049001220003	2023-11-13
Test software	3C test	V4.2.8	ES049001220003	129 28

Report No.: TH2212087-C01-R01 Page 8 of 37 EN 55032 Report

4 - CONDUCTED EMISSION MEASUREMENT

4.1 BLOCK DIAGRAM OF TEST SETUP



4.2 LIMITS

Frequency range	Class A Limits (dBµV)			
(MHz)	Quasi-peak	Average		
0.15 ~ 0.5	79	66		
0.50 ~ 30	73	60		

4.3 TEST PROCEDURE

The EUT is put on the plane 0.8m high above the ground by insulating support and connected to the AC mains through a Line Impedance Stability Network (L.I.S.N). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are investigated to find out the maximum conducted emission according to the EN 55032 regulations during conducted emission measurement.

The bandwidth of the field strength meter is set at 9kHz.

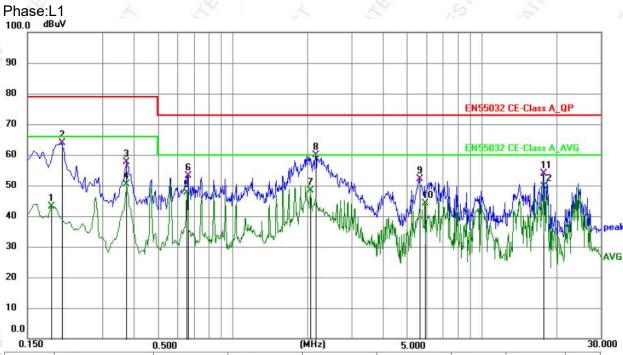
The frequency range from 150kHz to 30MHz is investigated. The scanning waveform please refer to the next page.

Report No.: TH2212087-C01-R01 Page 9 of 37 EN 55032 Report

4.4 TEST RESULTS AND DATA

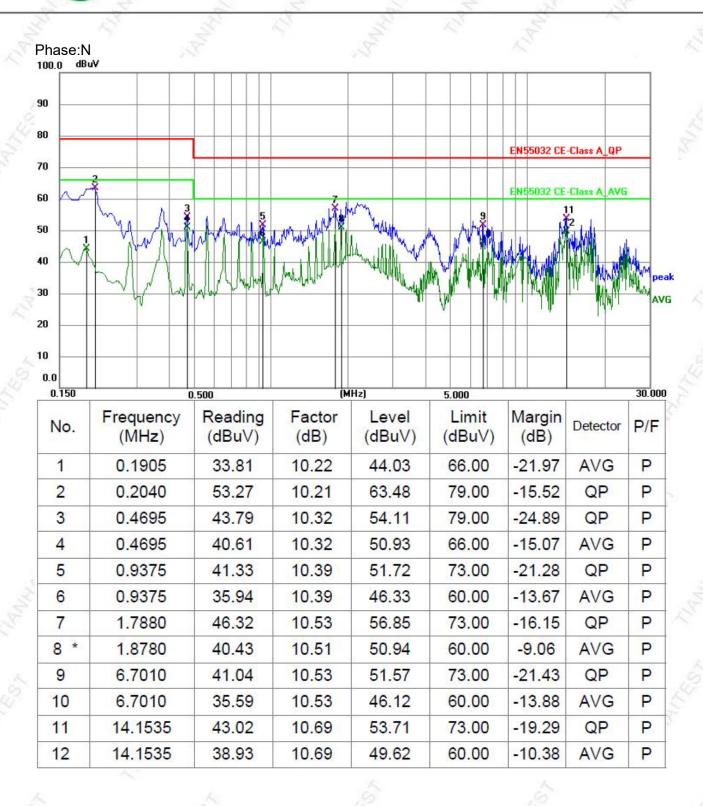
EUT: E1/T1 Gateway
M/N: DGW-L301
Test Mode: Mode A.1
Test Voltage: AC 230V/50Hz

Temperature: 23° C Humidity: 55% Atmosphere pressure: 101Kpa Test Results: Pass



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F
1	0.1860	33.03	10.21	43.24	66.00	-22.76	AVG	Р
2	0.2040	53.57	10.22	63.79	79.00	-15.21	QP	Р
3	0.3750	47.25	10.28	57.53	79.00	-21.47	QP	Р
4	0.3750	40.10	10.28	50.38	66.00	-15.62	AVG	Р
5	0.6540	37.20	10.35	47.55	60.00	-12.45	AVG	Р
6	0.6585	42.82	10.35	53.17	73.00	-19.83	QP	Р
7	2.0625	38.00	10.46	48.46	60.00	-11.54	AVG	Р
8	2.1525	49.30	10.46	59.76	73.00	-13.24	QP	Р
9	5.6030	41.58	10.44	52.02	73.00	-20.98	QP	Р
10	5.9090	33.80	10.45	44.25	60.00	-15.75	AVG	Р
11	17.6950	42.95	10.82	53.77	73.00	-19.23	QP	Р
12 *	17.6950	38.79	10.82	49.61	60.00	-10.39	AVG	Р

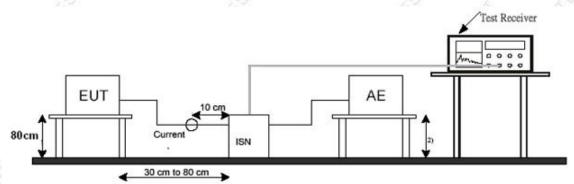
Report No.: TH2212087-C01-R01 Page 10 of 37 EN 55032 Report



Report No.: TH2212087-C01-R01 Page 11 of 37 EN 55032 Report

5 - ASYMMETRIC MODE CONDUCTED EMISSION MEASUREMENT

5.1 BLOCK DIAGRAM OF TEST SETUP



- 1) Distance to the ground reference plane (vertical or horizontal).
- 2) Distance to the ground reference plane is not critical.

5.2 LIMITS

Frequency range	Class A Lim	its (dBµV)
(MHz)	Quasi-peak	Average
0.15 ~ 0.5	97 to 87	84 to 74
0.50 ~ 30	87	74

5.3 TEST PROCEDURE

The EUT is put on the plane 0.8m high above the ground by insulating support and selecting ISN for unscreened cable or a current probe for screened cable to take measurement.

The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.

Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.

The bandwidth of the field strength meter is set at 9kHz.

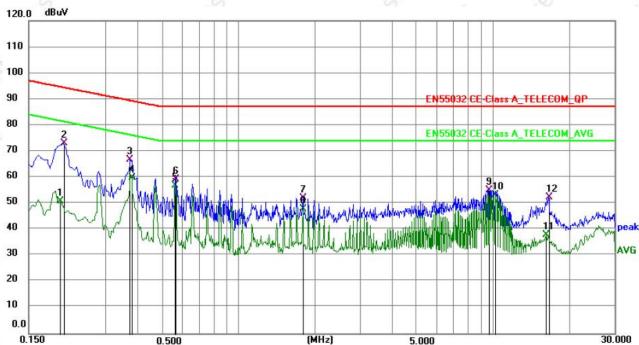
The frequency range from 150kHz to 30MHz is investigated. The scanning waveform please refer to the next page.

Report No.: TH2212087-C01-R01 Page 12 of 37 EN 55032 Report

5.4 TEST RESULTS AND DATA

EUT: E1/T1 Gateway M/N: DGW-L301 Test Mode: Mode A.2 Test Voltage: AC 230V/50Hz

Temperature: 23° C Humidity: 55% Atmosphere pressure: 101Kpa Test Results: Pass



0.130		0.500		anzj	5.000		30.00	
No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F
1	0.1995	30.78	19.96	50.74	81.63	-30.89	AVG	Р
2	0.2040	53.17	19.96	73.13	94.45	-21.32	QP	Р
3	0.3750	46.78	19.83	66.61	89.39	-22.78	QP	Р
4 *	0.3795	40.05	19.83	59.88	76.29	-16.41	AVG	Р
5	0.5639	37.01	19.79	56.80	74.00	-17.20	AVG	Р
6	0.5685	39.56	19.79	59.35	87.00	-27.65	QP	Р
7	1.7925	32.29	19.68	51.97	87.00	-35.03	QP	Р
8	1.7925	28.27	19.68	47.95	74.00	-26.05	AVG	Р
9	9.6260	35.47	19.62	55.09	87.00	-31.91	QP	Р
10	10.1889	33.65	19.62	53.27	74.00	-20.73	AVG	Р
11	16.2099	18.35	19.71	38.06	74.00	-35.94	AVG	Р
12	16.5295	32.72	19.72	52.44	87.00	-34.56	QP	Р

Report No.: TH2212087-C01-R01 Page 13 of 37 EN 55032 Report

6 - RADIATED DISTURBANCE MEASUREMENT

6.1 BLOCK DIAGRAM OF TEST SETUP

Below 1GHz

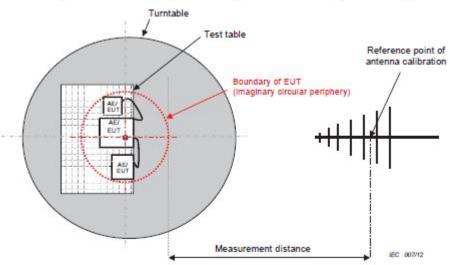


Figure C.1 - Measurement distance

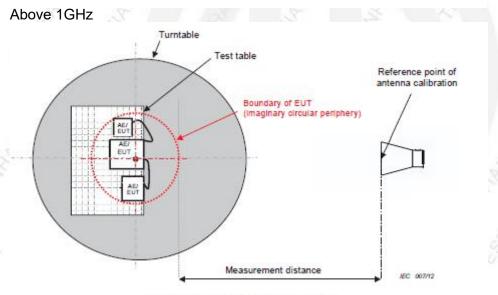


Figure C.1 - Measurement distance

6.2 LIMITS

Below 1GHz

Frequency (MHz)	Class A Quasi-peak Limits at 3m dB(μV/m)		
30-230	50		
230-1000	57		

Report No.: TH2212087-C01-R01 Page 14 of 37 EN 55032 Report

Above 1GHz

Frequency (MHz)	Class A Limits at 3m				
requeries (iiii iz)	Peak dB(μV/m)	Average			
1000-3000	76	56			
3000-6000	80	60			

6.3 TEST PROCEDURE

- a. The Product was placed on the non-conductive turntable 0.8/0.1 m above the ground at a chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW(Below 1GHz), 1MHz RBW(Above 1GHz). Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP or peak value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector / peak / AVG, and specified bandwidth with Maximum Hold Mode, and record the maximum value.

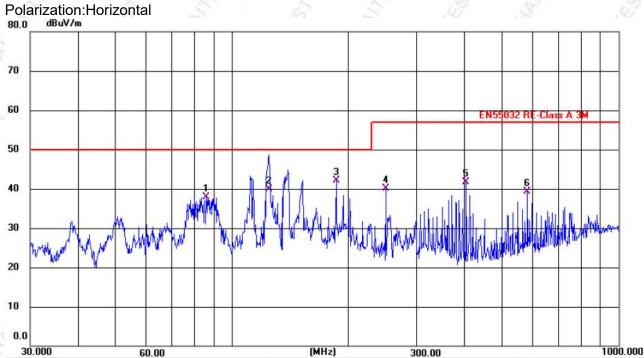
Report No.: TH2212087-C01-R01 Page 15 of 37 EN 55032 Report

6.4 TEST RESULTS AND DATA

Below 1GHz

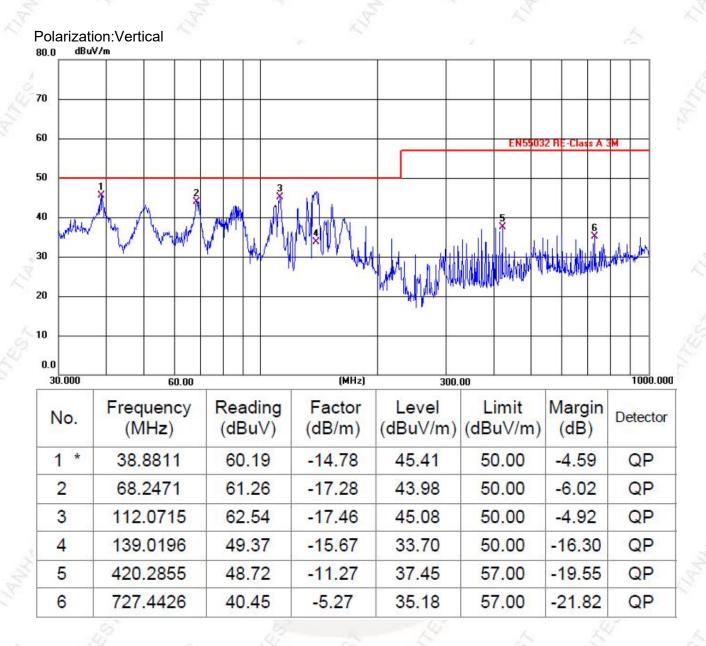
EUT: E1/T1 Gateway M/N: **DGW-L301** Test Mode: Mode A.1 Test Voltage: AC 230V/50Hz

Temperature: **26**℃ Humidity: 54% Atmosphere pressure: 101Kpa Test Results: **Pass**



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
1	85.5975	57.31	-19.49	37.82	50.00	-12.18	QP
2	124.5690	56.47	-16.57	39.90	50.00	-10.10	QP
3 *	185.7881	59.90	-17.84	42.06	50.00	-7.94	QP
4	249.4250	56.37	-16.27	40.10	57.00	-16.90	QP
5	403.2500	53.32	-11.67	41.65	57.00	-15.35	QP
6	580.7025	47.12	-7.85	39.27	57.00	-17.73	QP

Report No.: TH2212087-C01-R01 Page 16 of 37 EN 55032 Report



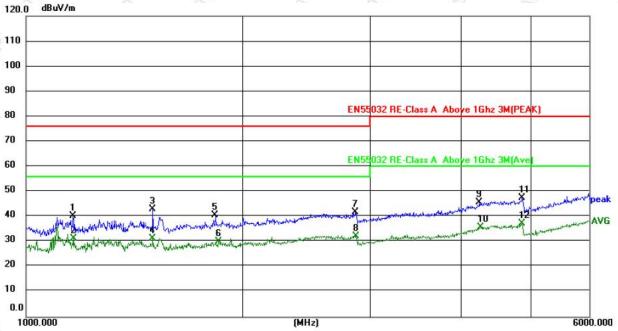
Report No.: TH2212087-C01-R01 Page 17 of 37 EN 55032 Report

Above 1GHz

EUT: E1/T1 Gateway
M/N: DGW-L301
Test Mode: Mode A.1
Test Voltage: AC 230V/50Hz

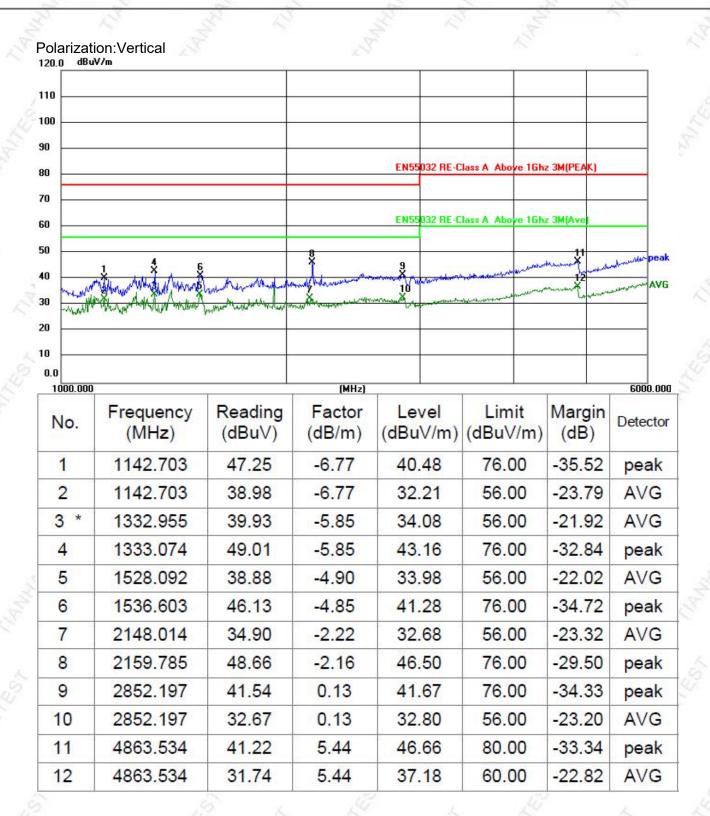
Temperature: 26° C Humidity: 54% Atmosphere pressure: 101Kpa Test Results: Pass

Polarization:Horizontal



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
1	1162.112	48.39	-8.03	40.36	76.00	-35.64	peak
2	1162.841	39.50	-8.03	31.47	56.00	-24.53	AVG
3	1497.330	49.30	-6.30	43.00	76.00	-33.00	peak
4	1497.330	37.70	-6.30	31.40	56.00	-24.60	AVG
5	1827.951	45.26	-4.73	40.53	76.00	-35.47	peak
6	1845.889	34.80	-4.66	30.14	56.00	-25.86	AVG
7	2854.754	44.03	-2.27	41.76	76.00	-34.24	peak
8	2863.463	34.50	-2.26	32.24	56.00	-23.76	AVG
9	4234.487	43.57	2.10	45.67	80.00	-34.33	peak
10	4250.070	33.83	2.13	35.96	60.00	-24.04	AVG
11	4857.437	44.44	3.22	47.66	80.00	-32.34	peak
12 *	4857.437	34.16	3.22	37.38	60.00	-22.62	AVG

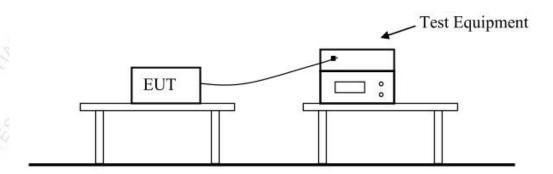
Report No.: TH2212087-C01-R01 Page 18 of 37 EN 55032 Report



Report No.: TH2212087-C01-R01 Page 19 of 37 EN 55032 Report

7 - HARMONIC CURRENT EMISSION MEASUREMENT

7.1 BLOCK DIAGRAM OF TEST SETUP



7.2 TEST STANDARD

Please refer to EN IEC 61000-3-2:2019+A1:2021

7.3 TEST PROCEDURE

- a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the maximum harmonic components under normal Test Modes for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from Product was chosen. The measure time shall be not less than the time necessary for the Product to be exercised.

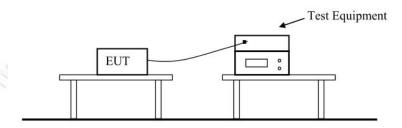
7.4 TEST RESULTS

PASS

Report No.: TH2212087-C01-R01 Page 20 of 37 EN 55032 Report

8 - VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT

8.1 BLOCK DIAGRAM OF TEST SETUP



8.2 TEST STANDARD

Please refer to EN 61000-3-3:2013+A1:2019+A2:2021

8.3 TEST PROCEDURE

- a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the most unfavorable sequence of voltage changes under normal Test Modes.
- b. During the flick test, the measure time shall include that part of whole operation cycle in which the Product procedure the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

8.4 TEST RESULTS

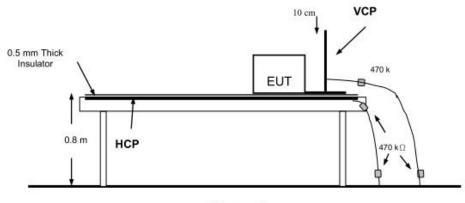
PASS

Report No.: TH2212087-C01-R01 Page 21 of 37 EN 55032 Report

9 - IMMUNITY TEST

9.1 ELECTROSTATIC DISCHARGE IMMUNITY TEST

9.1.1 BLOCK DIAGRAM OF TEST SETUP



Ground

9.1.2 TEST SPECIFICATION

Basic Standard : IEC 61000-4-2:2008
Test Port : Enclosure port
Discharge Impedance : 330 ohm / 150 pF

Discharge Mode : Single Discharge
Discharge Period : one second between each discharge

9.1.3 TEST PROCEDURE

9.1.3.1. Air Discharge

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all

the air discharge completed.

9.1.3.2. Contact Discharge

All the procedure shall be same as Section 9.1. except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

9.1.3.3. Indirect Discharge for Horizontal Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

9.1.3.4. Indirect Discharge for Vertical Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

Report No.: TH2212087-C01-R01 Page 22 of 37 EN 55032 Report

9.1.4 TEST RESULTS

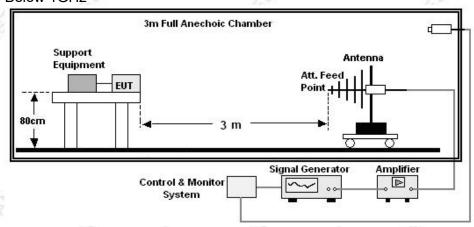
Electrostatic Discharge						
Basic Standard:	IEC 61000-4-2:2008	1/4	7	6 6		
EUT:	E1/T1 Gateway	- 1	16	. N.		
M/N:	DGW-L301	34	9	2		
Test Mode:	Mode A.1	The	75,	111	3	
Test Voltage :	AC 230V/50Hz		The same		18	
Temperature:	24 °C			7		
Humidity:	60%	A.		1652		
Atmosphere pressure:	101Kpa	16	25		. 6	

Discharge Method	Discharge Position	Voltage (±kV)	Min. No. of Discharge per polarity (Each Point)	Performance criteria	Result
4	Metal surface, DC port, LAN port, E1/T1/J1 port, console port	2, 4	10	В	Pass
Contact Discharge	Indirect Discharge HCP	2, 4	10	В	Pass
"FILE	Indirect Discharge VCP	2, 4	10	В	Pass
Air Discharge	Insulating surfaces, Gaps	2, 4, 8	10	В	Pass

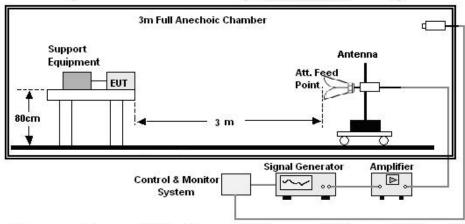
Report No.: TH2212087-C01-R01 Page 23 of 37 EN 55032 Report

9.2 RADIO FREQUENCY ELECTROMAGNETIC FIELDS 9.2.1 BLOCK DIAGRAM OF TEST SETUP

Below 1GHz



Above 1GHz



9.2.2 TEST SPECIFICATION

Basic Standard : IEC 61000-4-3:2020 Test Port : Enclosure port

Step Size : 1%

Modulation : 1kHz, 80% AM

Dwell Time : 1 second

Polarization : Horizontal & Vertical

9.2.3 TEST PROCEDURE

- a. The testing was performed in a fully-anechoic chamber. The transmit antenna was located at a distance of 3 meters from the Product.
- b. The frequency range is swept from 80MHz to 1000MHz, 1800MHz, 2600MHz, 3500MHz, 6000MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10⁻³ decade/s. Where the frequency range is swept incrementally, the step size was 1%.
- c. The test was performed with the Product exposed to both vertically and horizontally polarized fields on each of the four sides.

Report No.: TH2212087-C01-R01 Page 24 of 37 EN 55032 Report

9.2.4 TEST RESULTS

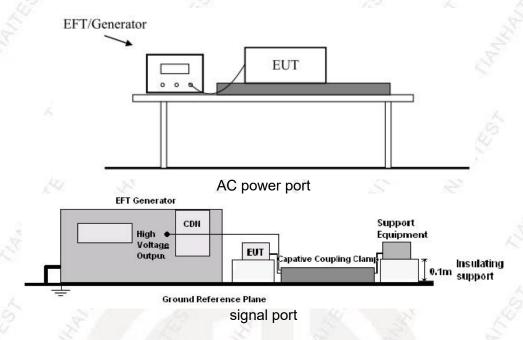
Radio frequency electromagnetic fields					
Basic Standard:	IEC 61000-4-3:2020	ς λ	9	8 8	
EUT:	E1/T1 Gateway	10 15		0 8	
M/N:	DGW-L301	9,	72	E	3
Test Mode:	Mode A.1	TIL	3	_	- 3
Test Voltage :	AC 230V/50Hz		74		1/10
Temperature:	24 °C	9		4	
Humidity:	60%	,60	×	24	
Atmosphere pressure:	101Kpa	700	150	· P	100

Frequency		Field Strength	Performance	
(MHz)	Position	(V/m)	criteria	Result
1	Front	3	Α	Pass
80 - 1000	Right	3	A	Pass
60 - 1000	Back	3	9 A	Pass
	Left	3	Α	Pass
F 3	Front	3	A	Pass
4000	Right	3	Α	Pass
1800	Back	3	Α	Pass
	Left	3	Α 🤌	Pass
K L	Front	3	Α	Pass
2000	Right	3	Α	Pass
2600	Back	3	A A A	Pass
	Left	3	Α	Pass
	Front	3	Α	Pass
2500	Right 3 A Back 3 A Left 3 A Front 3 A Right 3 A	Pass		
3500	Back	3	A /	Pass
	Left	3	X A 1/4	Pass
730	Front	3	A	Pass
6000	Right	3	A	Pass
6000	Back	3	Α	Pass
	Left	3	Α	Pass

Report No.: TH2212087-C01-R01 Page 25 of 37 EN 55032 Report

9.3 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.3.1 BLOCK DIAGRAM OF TEST SETUP



9.3.2 TEST SPECIFICATION

Basic Standard : IEC 61000-4-4:2012

Test Port : input a.c.power/signal port

Impulse Frequency: 5 kHzImpulse Wave-shape: 5/50 nsBurst Duration: 15 msBurst Period: 300 ms

Test Duration : 2 minutes per polarity

9.3.3 TEST PROCEDURE

The EUT is put on the table which is 0.8 meter high above the ground. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

9.3.3.2 For input and output AC power ports:

The EUT is connected to the AC power by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 mins.

9.3.3.1. For signal lines and control lines ports:

The EUT is connected to the signal line by using a coupling device which couples the EFT interference signal to signal lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 mins.

9.3.3.3. For DC output line ports:

No DC output ports. It's unnecessary to test.

Report No.: TH2212087-C01-R01 Page 26 of 37 EN 55032 Report

9.3.4 TEST RESULTS

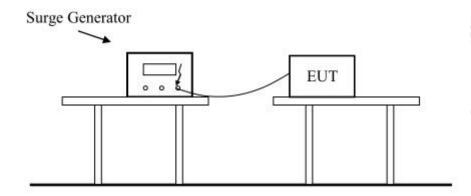
Electrical Fast Transient/Burst					
Basic Standard:	IEC 61000-4-4:2012				
EUT:	E1/T1 Gateway				
M/N:	DGW-L301				
Test Mode:	Mode A.1				
Test Voltage :	AC 230V/50Hz				
Temperature:	24 °C				
Humidity:	60%				
Atmosphere pressure:	101Kpa				

Line	Polarity	Test Voltage	Performance criteria	Result
AL.	±	±1kV	В	Pass
N	S ±	±1kV	В	Pass
L - N	± ±	±1kV	В	Pass
LAN	±	±0.5kV	В	Pass

Report No.: TH2212087-C01-R01 Page 27 of 37 EN 55032 Report

9.4 SURGE IMMUNITY TEST

9.4.1 BLOCK DIAGRAM OF TEST SETUP



9.4.2 TEST SPECIFICATION

Basic Standard IEC 61000-4-5:2014+AMD1:2017
Test Port input a.c. power port /signal port

Wave-Shape Open Circuit Voltage - 1.2 / 50 us, 10/700us

Short Circuit Current - 8 / 20 us, 8/320us

Pulse Repetition Rate 1 pulse / min.

Test Events Five positive polarity pulses at the 90° phase angel

Five negative polarity pulses at the 270° phase angel

9.4.3 TEST PROCEDURE

- 9.4.1.1. Set up the EUT and test generator as shown on Section 9.4.1.
- 9.4.1.2. For line to line coupling mode, provide a 1.0 KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 9.4.1.3. For Lan port to ground coupling mode, provide a 0.5 KV 10/700us voltage surge (at open-circuit condition) and 8/320us current surge to EUT selected points.
- 9.4.1.4. At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test
- 9.4.1.5. Different phase angles are done individually.
- 9.4.1.6. Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

Report No.: TH2212087-C01-R01 Page 28 of 37 EN 55032 Report

9.4.4 TEST RESULTS

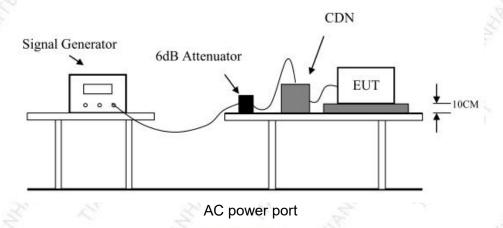
SURGE IMMUNITY					
Basic Standard: IEC 61000-4-5:2014+AMD1:2017					
EUT:	E1/T1 Gateway				
M/N:	DGW-L301	3			
Test Mode:	Mode A.1	2			
Test Voltage :	AC 230V/50Hz				
Temperature:	24 °C				
Humidity:	60%	A			
Atmosphere pressure:	101Kpa	7			

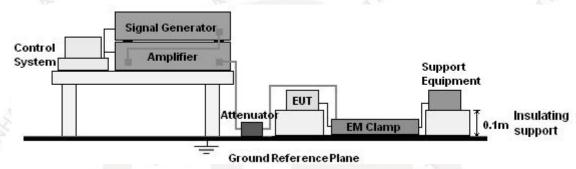
Coupling Line	Voltage (kV)	Phase Angle	Performance criteria	Result
L - N	+1KV	90	В	Pass
	-1KV	270°	В	Pass
LAN	±0.5kV	1	В	Pass

Report No.: TH2212087-C01-R01 Page 29 of 37 EN 55032 Report

9.5 INJECTED CURRENTS SUSCEPTIBILITY TEST

9.5.1 BLOCK DIAGRAM OF TEST SETUP





Signal port

9.5.2 TEST SPECIFICATION

Basic Standard : IEC 61000-4-6:2013

Test Port : input a.c. power port / signal port

Step Size : 1%

Modulation : 1kHz,80% AM

Dwell Time : 1 second

9.5.3 TEST PROCEDURE

For a.c. / d.c. power port

- 9.5.3.1. Set up the EUT, CDN and test generators as shown on Section 9.5.1.
- 9.5.3.2. Let the EUT work in test mode and measure it.
- 9.5.3.3. The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 9.5.3.4. The disturbance signal described below is injected to EUT through CDN.
- 9.5.3.5. The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 9.5.3.6. The frequency range is swept from 150kHz to 10MHz using 3V, 10MHz to 30MHz using Report No.: TH2212087-C01-R01 Page 30 of 37 EN 55032 Report

3V to 1V,30MHz to 80MHz using 1V signal level, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave.

- 9.5.3.7. The rate of sweep shall not exceed 1.5*10 -3 decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 9.5.3.8. Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

For signal / control lines:

- 9.5.3.9. The Product and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support, and the telecommunication port under test was connected to support units through the current clamp.
- 9.5.3.10. The frequency range is swept from 150kHz to 10MHz using 3V, 10MHz to 30MHz using 3V to 1V,30MHz to 80MHz using 1V signal level, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave.
- 9.5.3.11. The rate of sweep shall not exceed 1.5*10 -3 decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 9.5.3.12. Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

9.5.4 TEST RESULTS

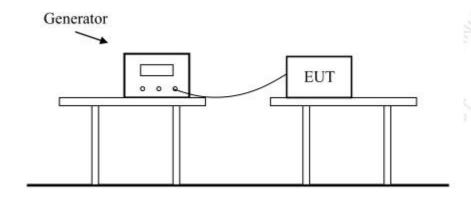
INJECTED CURRENTS SUSCEPTIBILITY				
Basic Standard:	IEC 61000-4-6:2013	132		
EUT:	E1/T1 Gateway	A 5"		
M/N:	DGW-L301	4 8		
Test Mode:	Mode A.1	F 5		
Test Voltage :	AC 230V/50Hz	1 Z C		
Temperature:	24 °C	18		
Humidity:	60%	7		
Atmosphere pressure:	101Kpa	49		

Frequency Range (MHz)	Injected Position	Strength (Non-modulated)	Performance criteria	Result
0.15 ~ 10	AC power	3V r.m.s.	A	Pass
10 ~ 30	AC power	3V r.m.s.to 1V r.m.s.	A	Pass
30 ~ 80	AC power	1V r.m.s.	Α 🔝	Pass
0.15 ~ 10	LAN	3V r.m.s.	Α	Pass
10 ~ 30	LAN	3V r.m.s.to 1V r.m.s.	Α	Pass
30 ~ 80	LAN	1V r.m.s.	A	Pass

Report No.: TH2212087-C01-R01 Page 31 of 37 EN 55032 Report

9.6 VOLTAGE DIPS AND INTERRUPTIONS TEST

9.6.1 BLOCK DIAGRAM OF TEST SETUP



9.6.2 TEST SPECIFICATION

Basic Standard : IEC 61000-4-11:2020 Test Port : input a.c. power port

Phase Angle : 0°, 180°

9.6.3 TEST PROCEDURE

9.6.3.1. Set up the EUT and test generator as shown on Section 9.6.1.

9.6.3.2. The interruptions is introduced at selected phase angles with specified duration.

9.6.3.3. Record any degradation of performance.

9.6.4 TEST RESULTS

VOLTAGE DIPS AND INTERRUPTIONS				
Basic Standard:	IEC 61000-4-11:2020			6
EUT:	E1/T1 Gateway		x x	4
M/N:	DGW-L301		0 10	
Test Mode:	Mode A.1	- 5	-200	- 4
Test Voltage :	AC 230V/50Hz and AC 120V/60Hz	17/7	130	-22
Temperature:	24 ℃	4		P.
Humidity:	60%	1		1
Atmosphere pressure:	101Kpa		_	

Test Level % UT	Voltage Dips & Short	Duration (in periods)		Performance	Result
	Interruptions % UT	50Hz	60Hz	criteria	Nesuit
< 5	100	0.5	0.5	В	Pass
70	30	25	30	C A	Pass
< 5	100	250	300	С	Pass

Report No.: TH2212087-C01-R01 Page 32 of 37 EN 55032 Report

APPENDIX A - EUT PHOTOGRAPHS

External Photos of EUT





Report No.: TH2212087-C01-R01 Page 33 of 37 EN 55032 Report







Report No.: TH2212087-C01-R01 Page 34 of 37 EN 55032 Report







Report No.: TH2212087-C01-R01 Page 35 of 37 EN 55032 Report







Report No.: TH2212087-C01-R01 Page 36 of 37 EN 55032 Report





********END OF THE REPORT********

Report No.: TH2212087-C01-R01 Page 37 of 37 EN 55032 Report